

# Search Notes



Application/Control No.

10/615,870

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

MACHIMURA ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	128	7/23/05	H2
"	144	"	"
Updated above using text search only -			
		11/14/05	H2

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG - PUB		Text search.	
		11/14/05	H2

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	7/23/05	H2
NPL search using terms similar to EAST search.	"	"
Inventorship search.	"	"
Updated EAST search.	11/14/05	H2